


<b>Search Notes</b>  	<b>Application/Control No.</b>  10726570	<b>Applicant(s)/Patent Under Reexamination</b>  MIYAJI, TAKESHI
	<b>Examiner</b>  Liu, Lin	<b>Art Unit</b>  2145

SEARCHED			
Class	Subclass	Date	Examiner
709	249	06/15/2007	L.L

SEARCH NOTES		
Search Notes	Date	Examiner
Text search of USPAT, USPGPUB, EPO, JPO, DERWENT, IBM_TDB, see search history printout.	06/18/2007	L.L
Limited classified search of 463/6, 42	06/18/2007	L.L
L1: 709/249.ccls. and (@ad<20031204) reviewed consicely	06/15/2007	L.L
709/249.ccls. not L1, reviewed cursory.	06/15/2007	L.L
Diaglog search attached	06/18/2007	L.L
Text search of USPAT, USPGPUB, EPO, JPO, DERWENT, IBM_TDB, see search history printout.	12/18/2007	L.L

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner